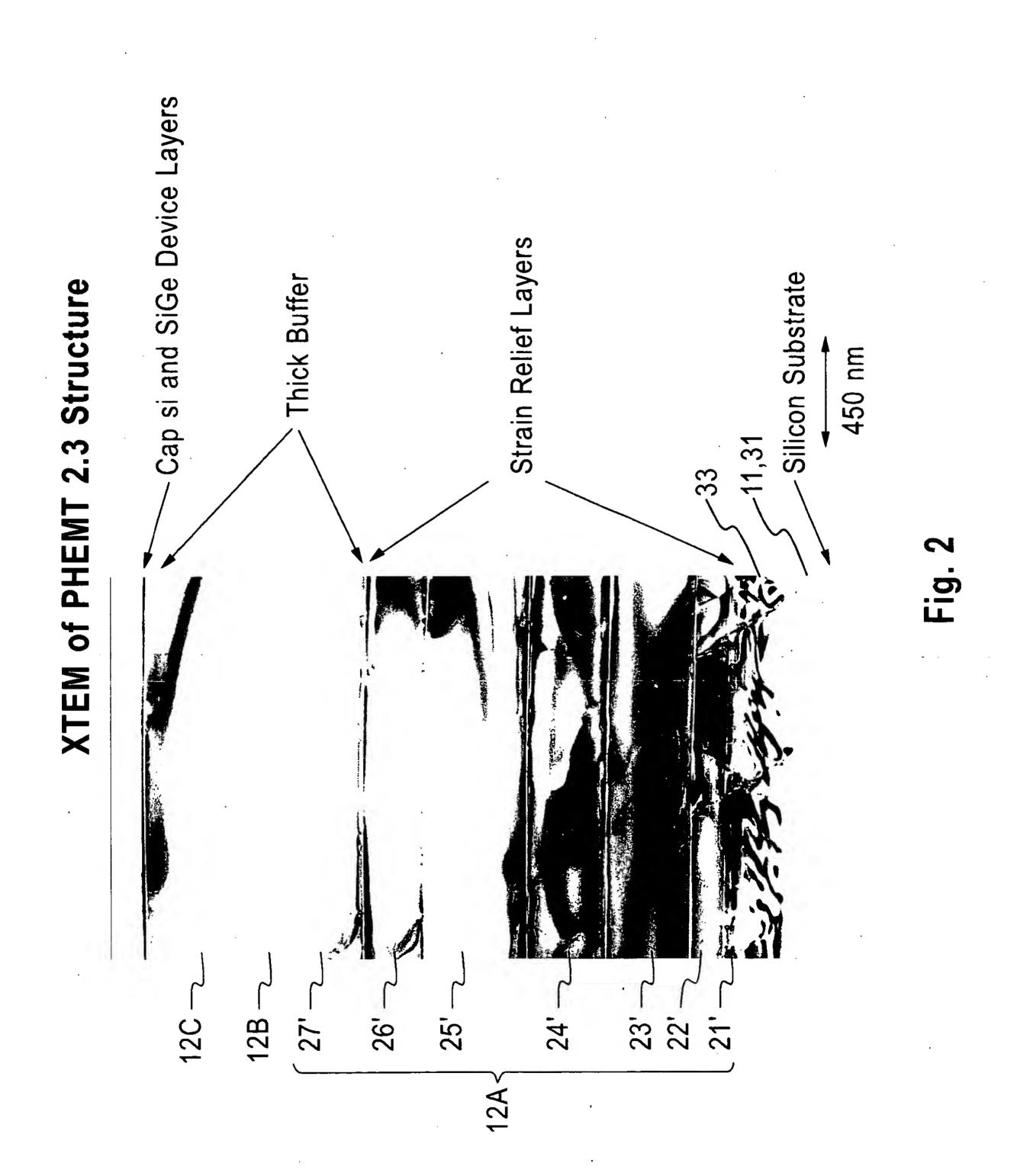
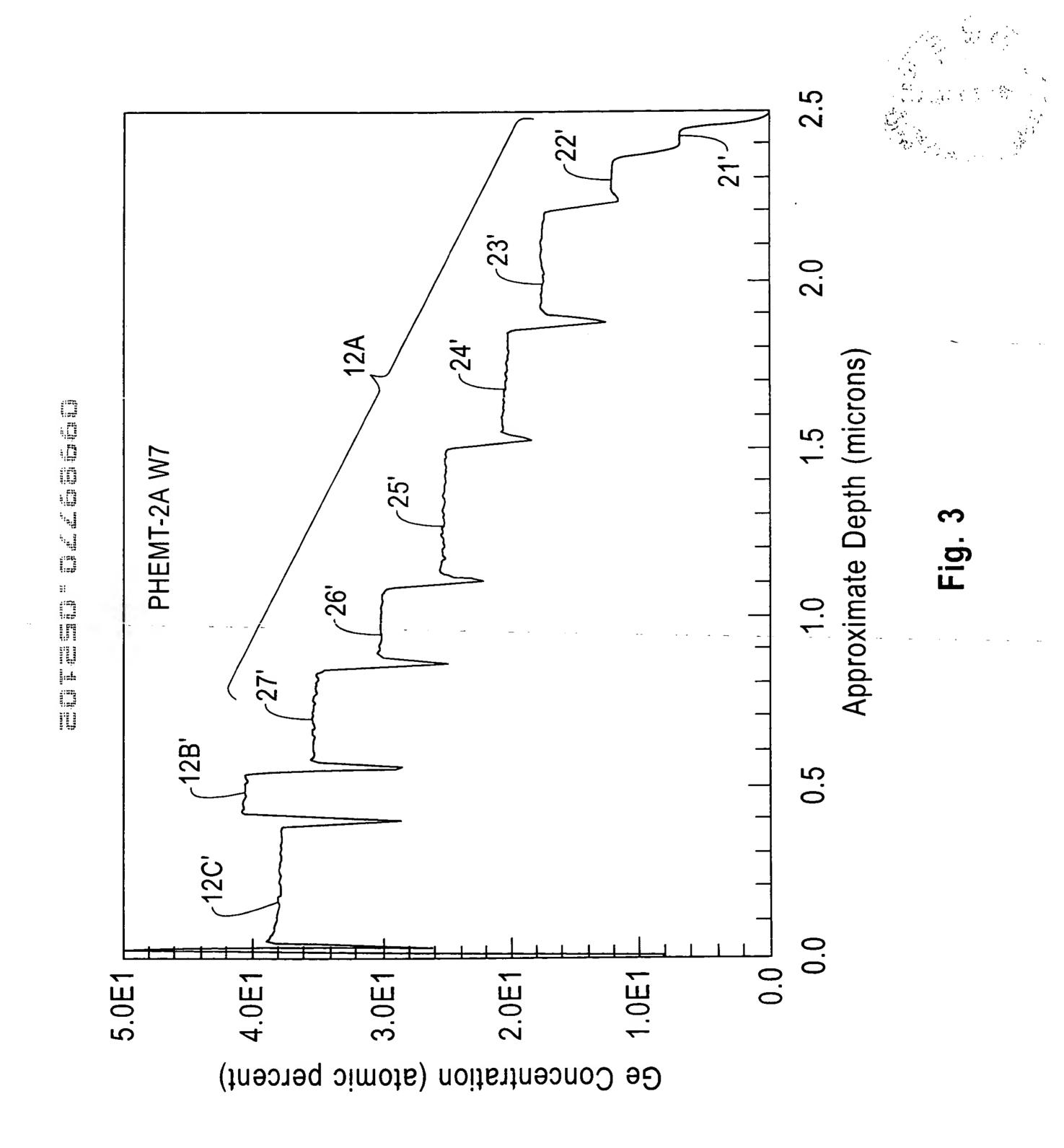


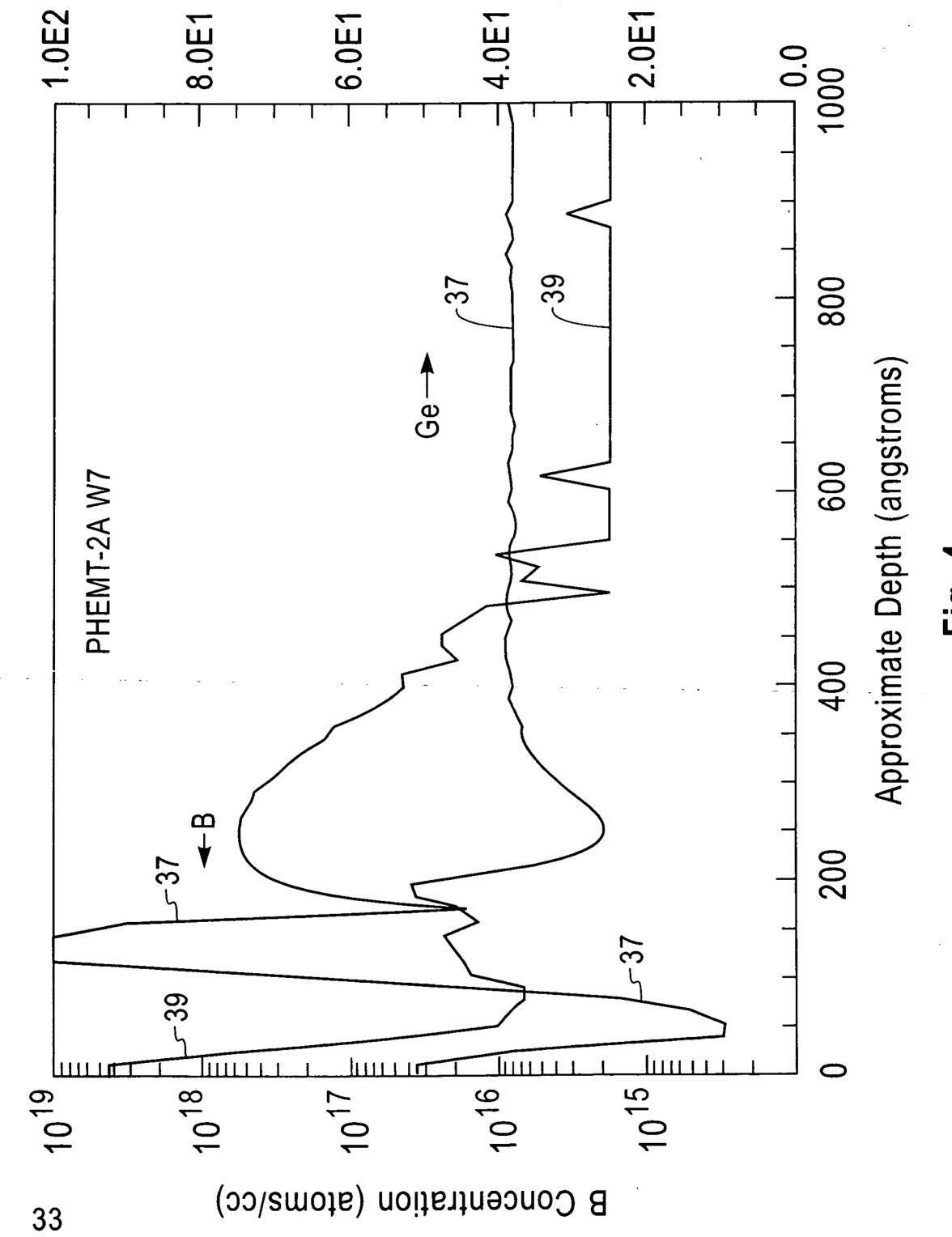
Fig. 1



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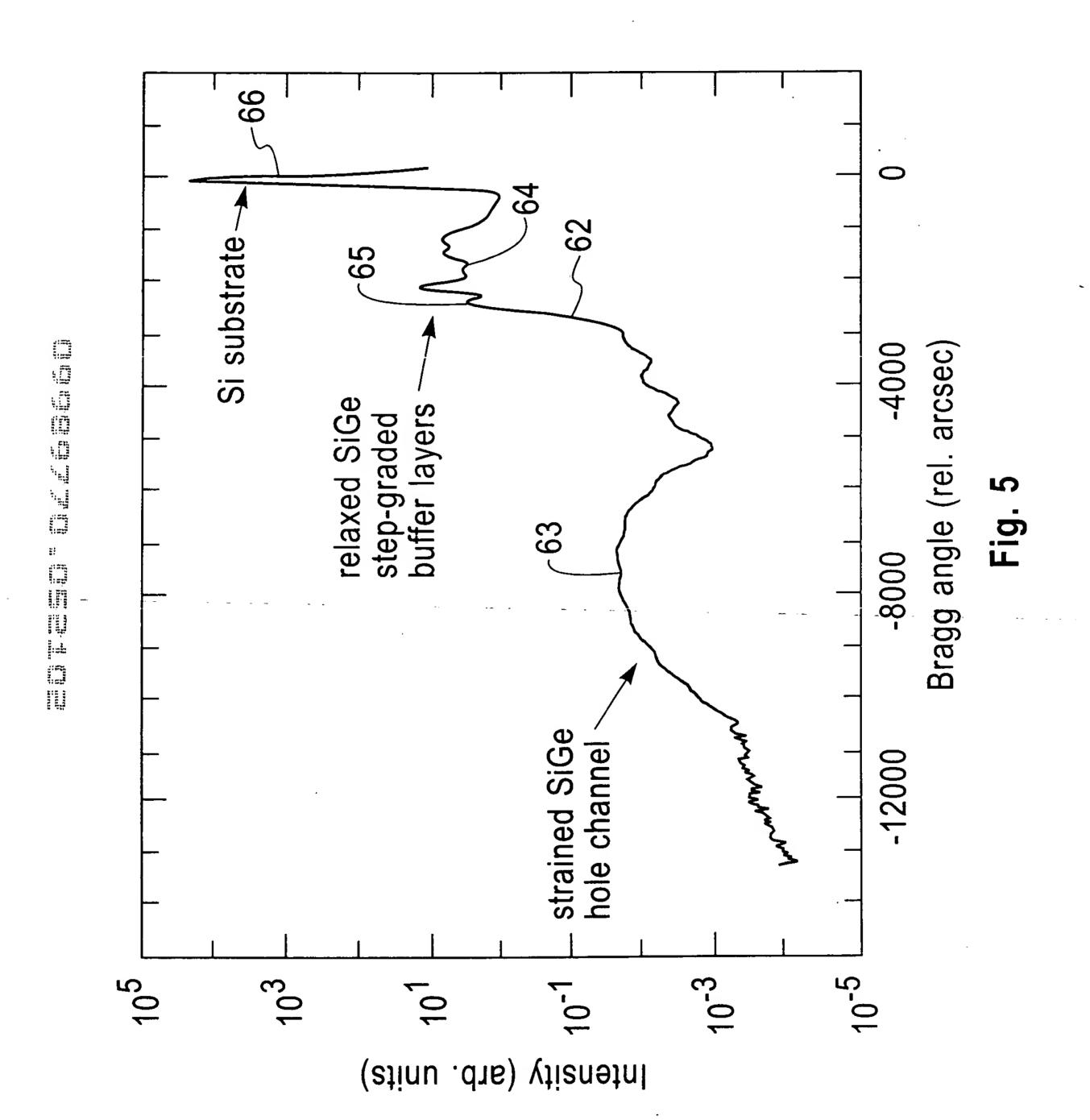
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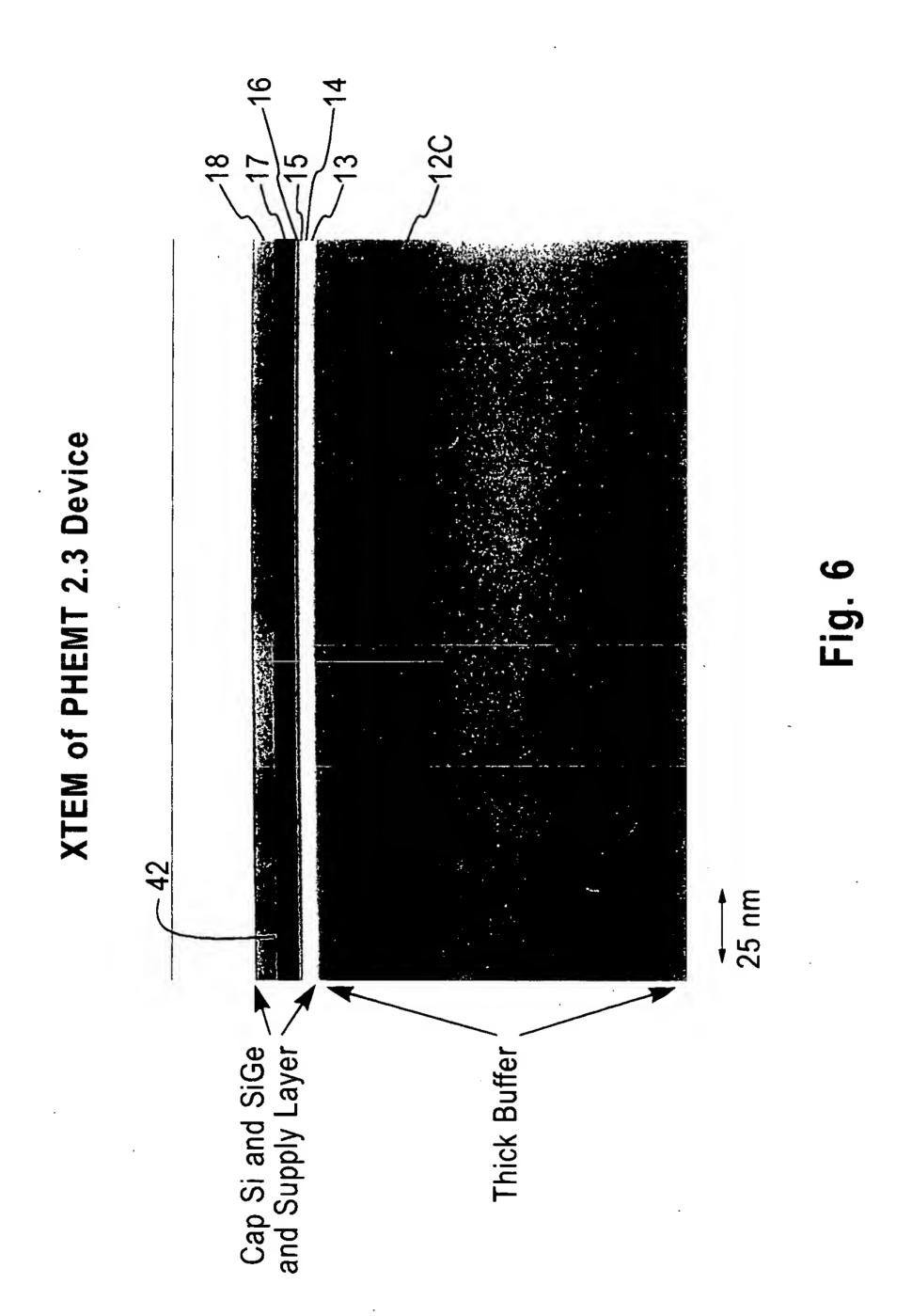




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Fig. 4





Stacking fault densities ~ 10⁶ - 10⁸/cm²

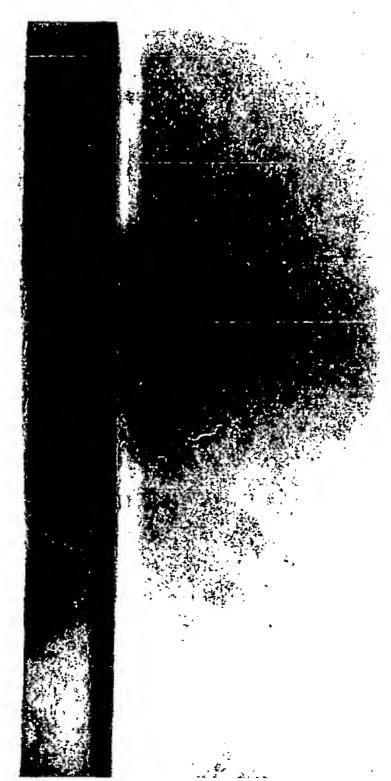


Fig.

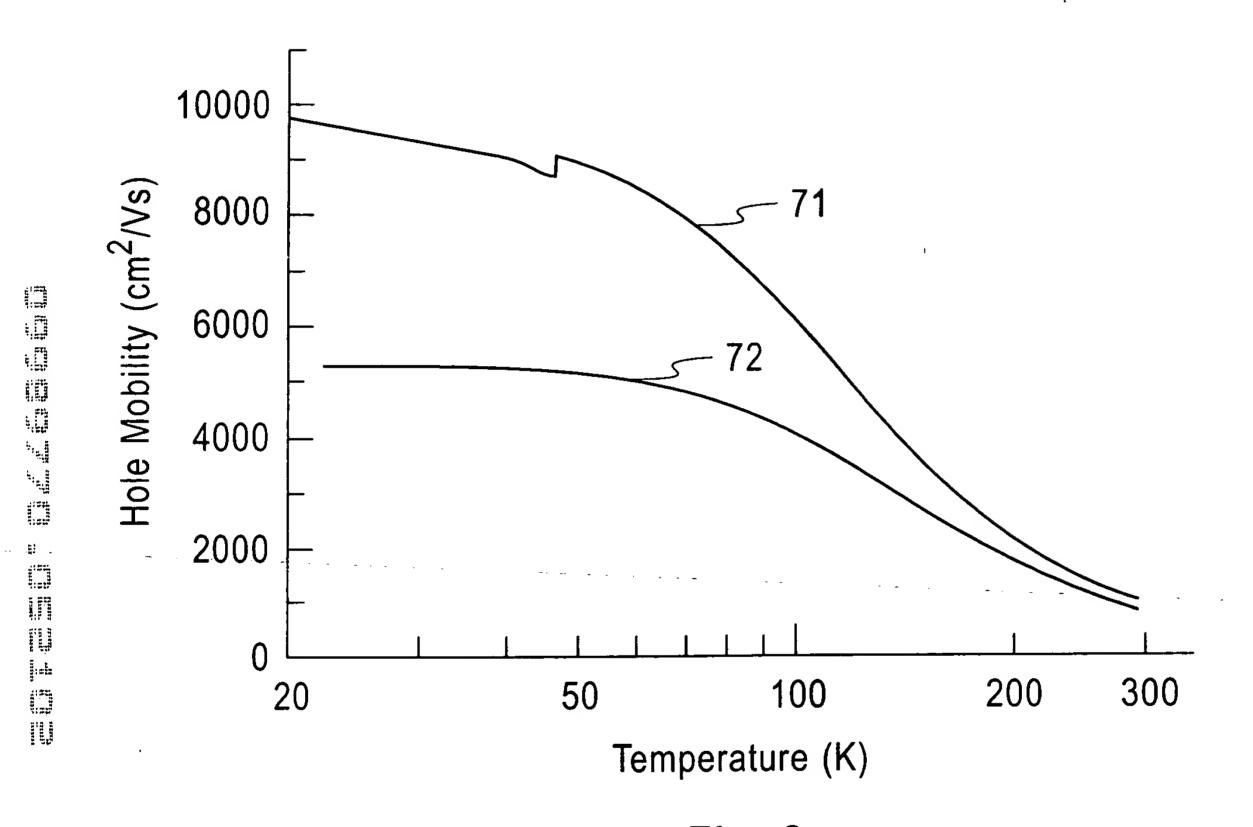


Fig. 8

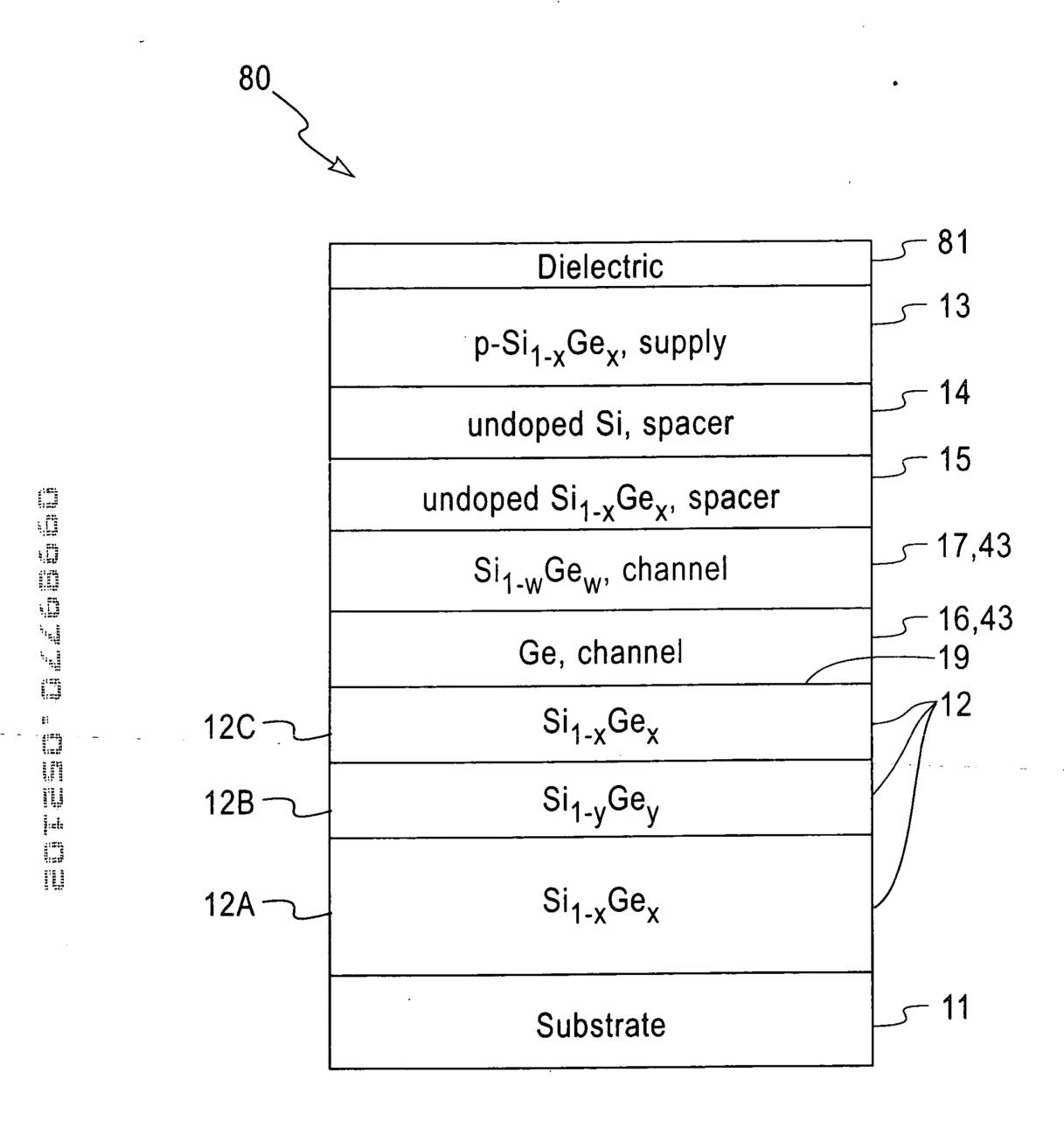
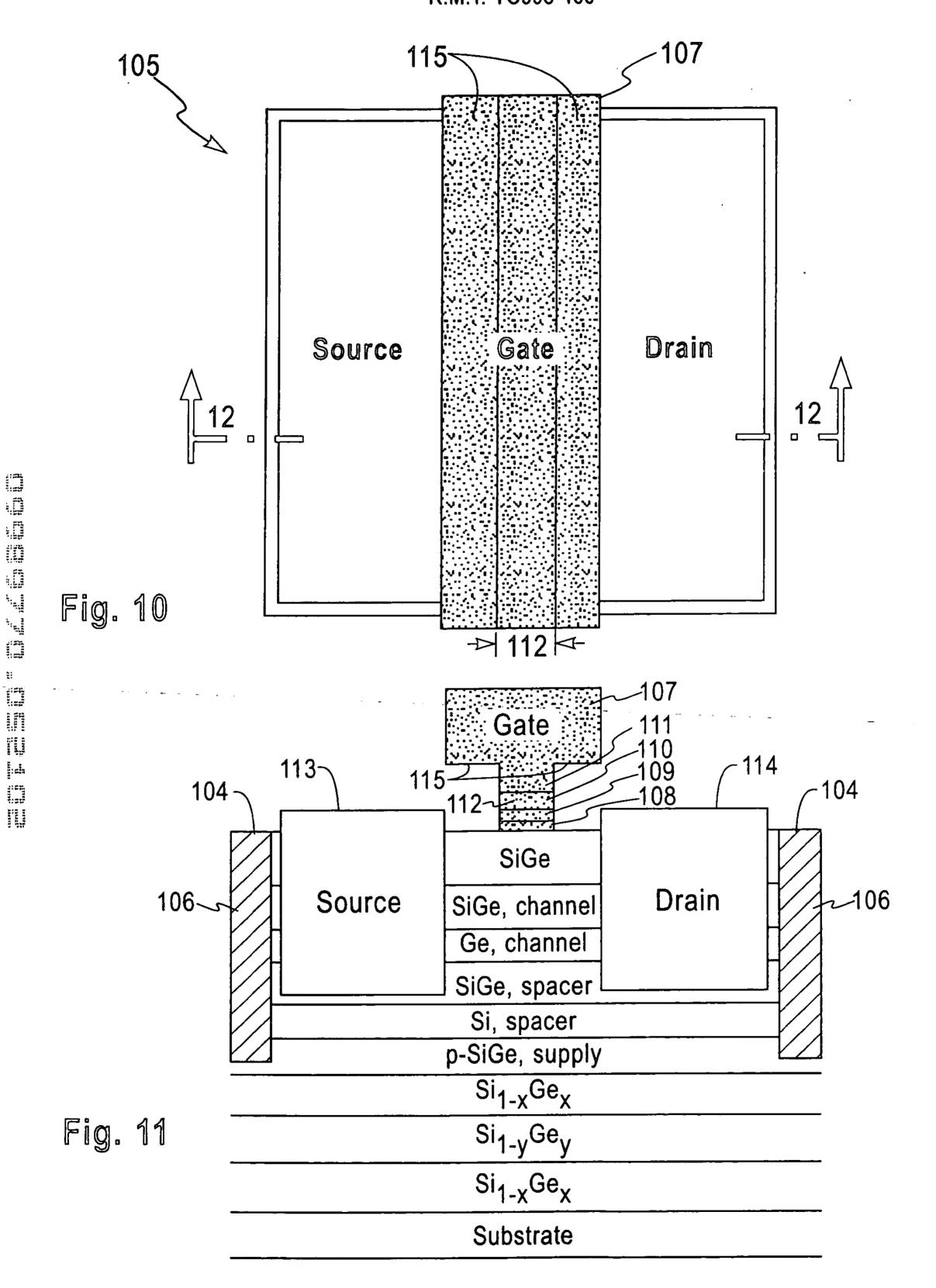
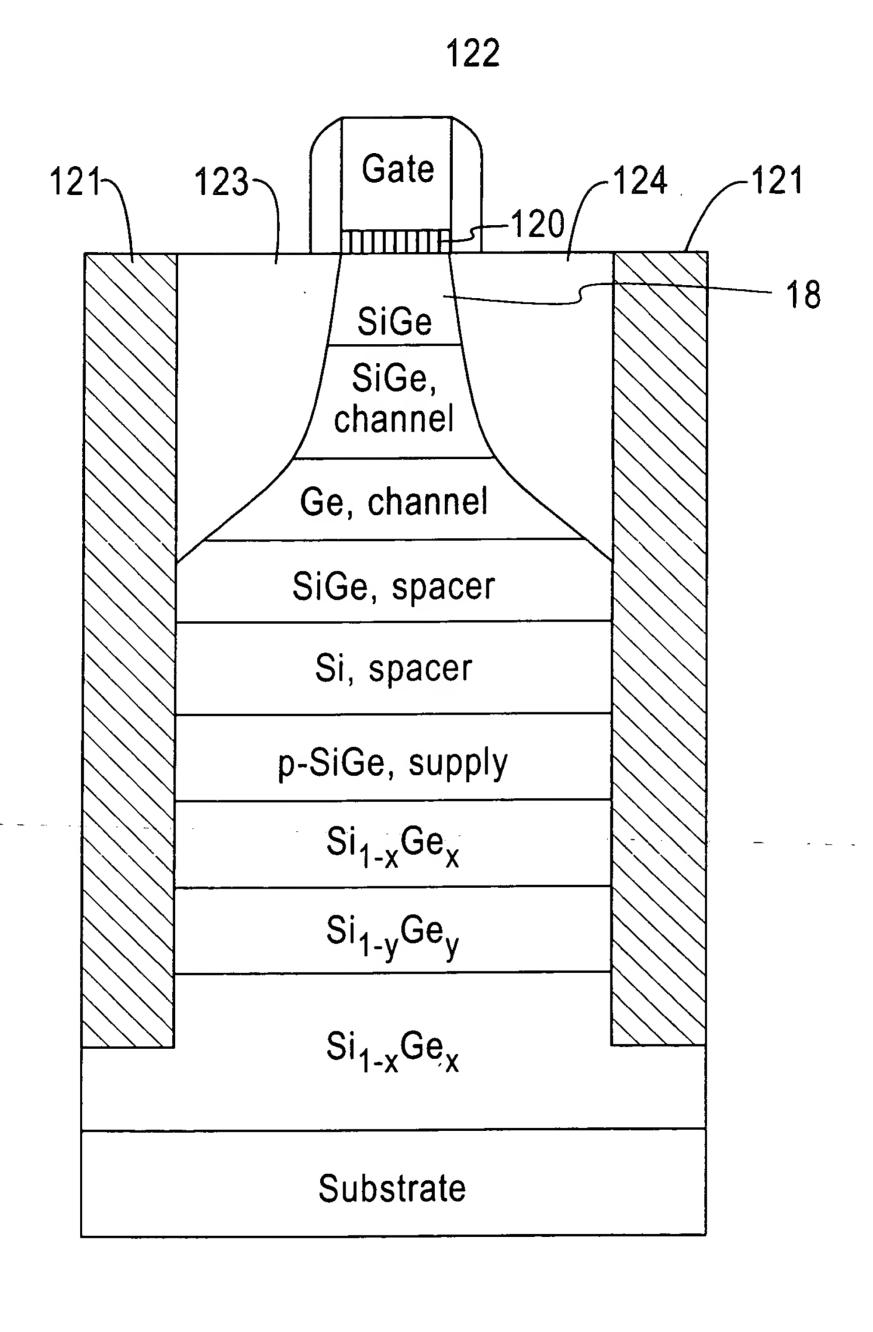


Fig. 9

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The three cases the transmitter of the transmitter

Fig. 12

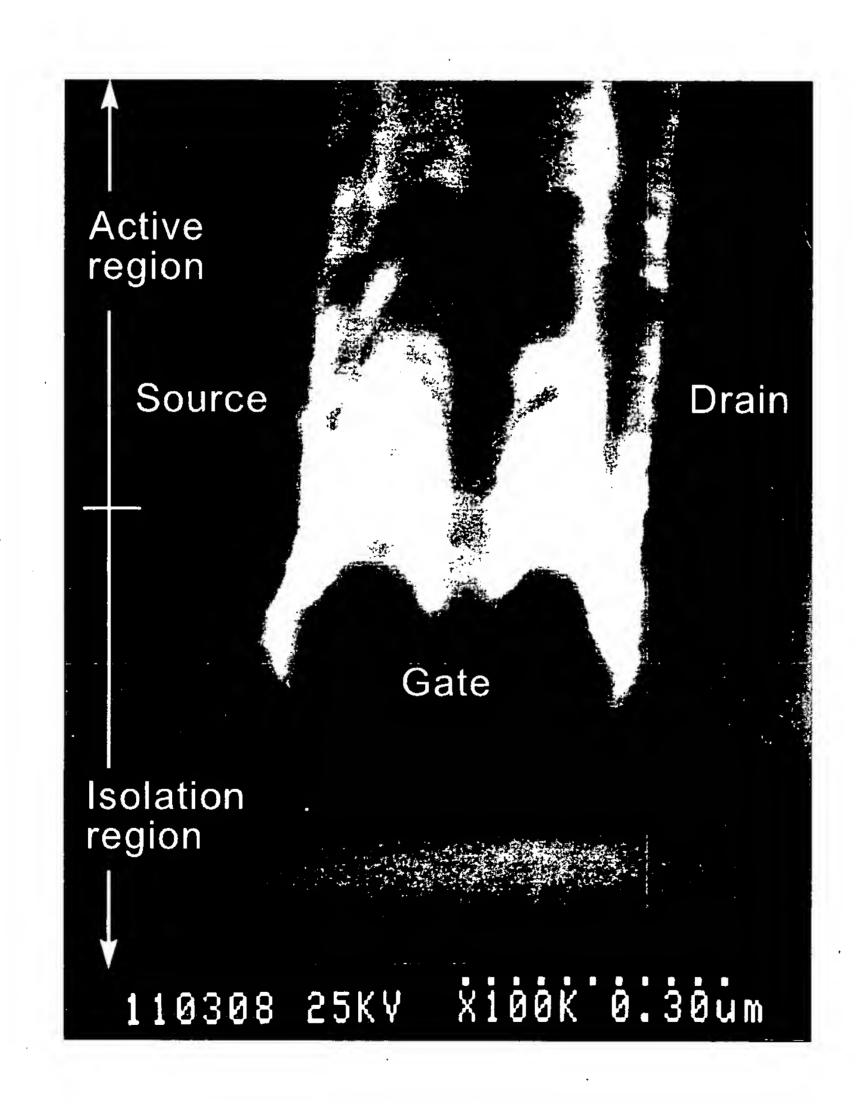


Fig. 13

p-type composite-channel MODFET, $L_g = 0.09 \mu m$, $W = 25 \mu m$

